

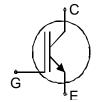
## IGBT Chip in NPT-technology

#### **FEATURES:**

- 600V NPT technology
- 100µm chip
- short circuit prove
- positive temperature coefficient
- · easy paralleling

## This chip is used for:

• IGBT-Modules



### **Applications:**

• drives

Chip Type	V <sub>CE</sub>	I <sub>Cn</sub>	Die Size	Package	Ordering Code	
SIGC61T60NC	600V	75A	6.99 x 8.79 mm <sup>2</sup>	sawn on foil	Q67050-A4160-	
010001100110	000 0	000 1 7 3 7	0.55 x 6.75 mm	Sawii dii idii	A001	

### **MECHANICAL PARAMETER:**

Raster size	6.99 x 8.79			
Area total / active	61.44 / 53.7			
Emitter pad size	2x( 2.98x5.48 )			
Gate pad size	0.8 x 1.5			
Thickness	100	μm		
Wafer size	150	mm		
Flat position	90	deg		
Max.possible chips per wafer	200			
Passivation frontside	Photoimide			
Emitter metallization	3200 nm Al Si 1%			
Collector metallization	1400 nm Ni Ag –system suitable for epoxy and soft solder die bonding			
Die bond	electrically conductive glue or solder			
Wire bond	AI, ≤500μm			
Reject Ink Dot Size	Ø 0.65mm; max 1.2mm			
Recommended Storage Environment	store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C			



#### **MAXIMUM RATINGS:**

Parameter	Symbol	Value	Unit
Collector-emitter voltage, T <sub>j</sub> =25 °C	V <sub>CE</sub>	600	V
DC collector current, limited by T <sub>jmax</sub>	I <sub>C</sub>	1)	Α
Pulsed collector current, t <sub>p</sub> limited by T <sub>jmax</sub>	I <sub>cpuls</sub>	225	А
Gate emitter voltage	V <sub>GE</sub>	±20	V
Operating junction and storage temperature	$T_j$ , $T_{stg}$	-55 <b>+</b> 150	°C

<sup>1)</sup> depending on thermal properties of assembly

## **STATIC CHARACTERISTICS** (tested on chip), $T_j$ =25 °C, unless otherwise specified:

Parameter	Symbol	Conditions	Value			Unit
- arameter		Conditions	min.	typ.	max.	
Collector-emitter breakdown voltage	$V_{(BR)CES}$	$V_{GE}$ =0V, $I_{C}$ =3mA	600			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	V <sub>GE</sub> =15V, I <sub>C</sub> =75A	1.7	2.1	2.5	V
Gate-emitter threshold voltage	$V_{\rm GE(th)}$	I <sub>C</sub> =1.5mA, V <sub>GE</sub> =V <sub>CE</sub>	4.5	5.5	6.5	
Zero gate voltage collector current	I <sub>CES</sub>	V <sub>CE</sub> =600V, V <sub>GE</sub> =0V			5.2	μA
Gate-emitter leakage current	I <sub>GES</sub>	V <sub>CE</sub> =0V, V <sub>GE</sub> =20V			210	nA

### **DYNAMIC CHARACTERISTICS** (tested at component):

Parameter	Symbol	Conditions	Value			Unit
raiailletei			min.	typ.	max.	Joint
Input capacitance	Ciss	V <sub>CE</sub> =25V	-	3300	-	pF
Output capacitance	Coss	V <sub>GE</sub> =0V	-	tbd	-	
Reverse transfer capacitance	Crss	f=1MHz	-	300	-	

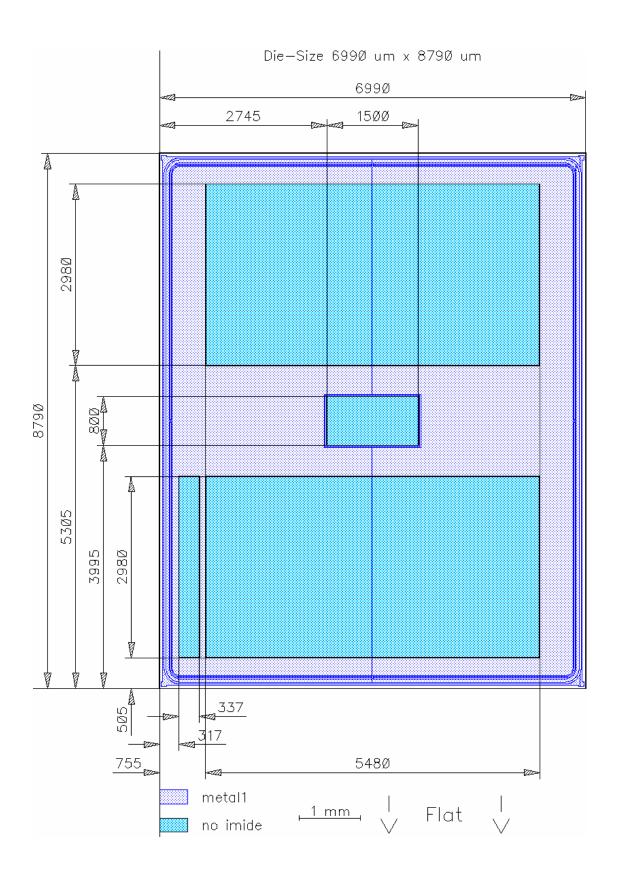
### **SWITCHING CHARACTERISTICS** (tested at component), Inductive Load:

Parameter	Symbol	Conditions 1)	Value			Unit
	Symbol		min.	typ.	max.	
Turn-on delay time	$t_{d(on)}$	T <sub>j</sub> =125°C V <sub>CC</sub> =300V	-	65	-	ns
Rise time	$t_{r}$	I <sub>C</sub> =75A	-	25	-	
Turn-off delay time	$t_{d(off)}$	$V_{\text{GE}} = \pm 15 \text{V}$ $R_{\text{G}} = 3\Omega$	-	170	-	
Fall time	$t_{\mathrm{f}}$	7.6-022	-	35	-	

<sup>1)</sup> values also influenced by parasitic L- and C- in measurement and package.



#### **CHIP DRAWING:**





#### **FURTHER ELECTRICAL CHARACTERISTICS:**

#### **Description:**

AQL 0,65 for visual inspection according to failure catalog

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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